

# Fourth-Order Statistics for Parameter Estimation

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## Abstract

Semblance is the mostly used coherence measure for parameter estimation from geophysical data. The best example is velocity analysis in which the normal-moveout velocity is extracted from common-midpoint (CMP) gathers. In complete analogy to velocity analysis, semblance is also applied to estimate Common-Reflection-Surface (CRS) parameters by means of the hyperbolic traveltimes applied to multicoverage data. In statistics, semblance is related to the so-called second moment and in optimization theory, to the least-squares solution of maximum signal energy as a characterization of reflection events. Extensions of the usual semblance can be defined by replacing second-order by higher-order quantities. Here we found encouraging results by a natural extension of semblance to fourth order. The introduced fourth-order semblance is applied to CRS parameter estimation. Numerical examples show that the search using fourth-order semblance is more reliable for high noise levels.

## Introduction

Since the famous work of Taner and Koehler (1969), semblance has been a reliable measure of coherence in seismic processing. Many applications like stacking velocity analysis (Yilmaz, 1979), migration velocity analysis (Al-Yahya, 1989; Schleicher and Biloti, 2007), filter techniques (Reiter et al., 1993) or CRS stack (see, e.g., Höcht et al., 1999) rely on semblance to detect the shape of reflection events in seismic data. Semblance is known to depend in various degrees on operator size (aperture and window length) and noise level (Douze and Laster, 1979). Moreover, it is based on the assumption of white noise. Therefore, it sometimes shows unpredictable behaviour if the noise is actually coloured. For these reasons, many attempts have been made to find a more stable measure of coherence that depends less on the kind of noise in the data or the choice of the parameters used in the analysis. One of the most successful ones is differential semblance (Symes and Kern, 1994).

Being a very robust and easy to calculate measure of coherence for a broad variety of situations, the second-order coherence measure semblance has survived all these attempts. Nonetheless, there exist particular situations,

where other coherency measures can be advantageous. In this paper, we compare its behaviour to those of a first- and a fourth-order coherence measure. We show that while in conventional velocity analysis, there is no gain in replacing semblance by one of the other measures, for the linear search of the CRS stack (Müller, 1999), the fourth-order measure is less dependent on aperture and noise level, thus resulting in reliable estimates of the local slope more often than when using conventional semblance.

## Interpretation of Semblance in Statistics

One important step in the CMP (or CRS) stacking process is to find pre-assigned curves or surfaces (e.g., hyperbolic curves) that fit the reflection traveltimes in some best possible way. Of paramount importance is an accurate determination of the parameters that define the best-fit curves or surfaces, as these convey most relevant information to be extracted from the seismic data. Of course, due to the presence of noise, these tasks can be very difficult. Therefore, it is necessary to have some measure to decide whether some curve/surface fits the traveltimes. One possibility for such a measure is the degree of *alignment or coherence* of the seismic traces along the trial curves/surfaces.

Semblance is a quantitative measure of coherence, typically used for event characterization in noisy data sets, for example seismic data. In a certain sense, semblance represents the energy of the stacked trace divided by the energy sum of all stacking traces within a given time window. Mathematically, semblance is defined as

$$\tilde{S}_2 = \left[ \sum_{k=-w}^w \left( \sum_{i=1}^N u_{ik} \right)^2 \right] / \left[ N \sum_{k=-w}^w \left( \sum_{i=1}^N u_{ik}^2 \right) \right]. \quad (1)$$

Here, the inner summation represents the traces (index  $i$ ) along which the stack is performed; the outer summation performs the stack for various time samples (index  $k$ ), that fall in a given time window of width  $2w + 1$ . The window width should be related to the length of the signal wavelet of the event. The summation enhances the signal-to-noise ratio of the resulting stack. In order to study semblance as a statistical or optimization concept, it is convenient to disregard the time-window summation. In other words, we shall, for the moment, define the *local semblance* as the simpler expression

$$S_2 = \left[ \left( \sum_{i=1}^N u_i \right)^2 \right] / \left[ N \sum_{i=1}^N u_i^2 \right]. \quad (2)$$

To describe the relationship between local semblance  $S_2$  and statistical quantities, it is convenient to consider, for a given sample  $(u_1, u_2, \dots, u_N)$ , the *simple moment of*

order  $m$ , or simply  $m$ -moment,  $\mu_m$ , defined by  $\mu_m = \left[ \sum_{i=1}^N u_i^m \right] / N$ ,  $m = 0, 1, \dots$ . We readily note that  $\mu_0 = 1$  and  $\mu_1$  is the standard *mean* or *average*. With the help of the above definitions, the local semblance  $S_2$  of equation (2) can be recast as

$$S_2 = \mu_1^2 / \mu_2. \quad (3)$$

To generalize the local semblance to a corresponding higher-order quantity (namely in terms of higher-order moments), we introduce the *central  $m$ -moments*  $\sigma_m = \left[ \sum_{i=1}^N (u_i - \mu_1)^m \right] / N$ ,  $m = 0, 1, \dots$ , for which  $\sigma_0 = 1$  and  $\sigma_1 = 0$ . In particular,  $\sigma_2$  is called the *variance*, which can be written as  $\sigma_2 = \mu_2 - \mu_1^2$ . The various quantities  $\sigma_m$  measure different dispersion attributes about the mean. Roughly speaking, the variance carries information about the concentration of the sample in some interval around the mean. A large value of the variance indicates a disperse distribution. A small variance means that the data is clustered around the mean.

For our purposes, we are only interested in moments of *even* order, in fact for definiteness, fourth order. We observe that the local semblance  $S_2$  is naturally related to the second-order moments (simple and central) by the relationship  $\sigma_2 = \mu_2 - \mu_1^2 = \mu_2(1 - \mu_1^2/\mu_2) = \mu_2(1 - S_2)$ , or, equivalently,

$$S_2 = 1 - \sigma_2/\mu_2. \quad (4)$$

Equation (4) is the key relation that enables us to extend the semblance concept to higher (even) orders. Here, we only consider the fourth order. In analogy to equation (4), we define the fourth-order “local semblance”  $S_4$  as

$$S_4 = 1 - \sigma_4/\mu_4 = (\mu_1/\mu_4) (4\mu_3 - 6\mu_1\mu_2 + 3\mu_1^3). \quad (5)$$

As our final expression for the fourth-order coherency measure, which will replace the usual (second-order) semblance, we re-introduce the (external) time-window ummation of the original semblance definition in equation (1). Thus, the final fourth-order semblance is defined as

$$\begin{aligned} \tilde{S}_4 &= \left[ \sum_{k=-w}^w \left( \sum_{i=1}^N u_{ik} \right) \left[ 4N^2 \left( \sum_{i=1}^N u_{ik}^3 \right) \right. \right. \\ &\quad \left. \left. - 6N \left( \sum_{i=1}^N u_{ik} \right) \left( \sum_{i=1}^N u_{ik}^2 \right) + 3 \left( \sum_{i=1}^N u_{ik} \right)^3 \right] \right] \\ &\quad / \left[ N^3 \sum_{k=-w}^w \left( \sum_{i=1}^N u_{ik}^4 \right) \right]. \end{aligned} \quad (6)$$

### Interpretation of Semblance in Optimization Theory

As mentioned earlier, semblance is used in the CMP or CRS stack as a measure of coherence along a specified trial curve or surface through the seismic data. Let the vector  $\mathbf{u} = (u_1, u_2, \dots, u_N)$  represent the amplitudes along some curve/surface in the seismic section, for some limited aperture around the central point that is being analysed. We may assume that these values must be reasonably constant if they are perfectly coherent, i.e., if they are aligned

along the correct traveltime curve/surface. Hence, we can find the  $N$ -dimensional constant vector  $\mathbf{c} = (x, x, \dots, x)$  that is “closest” to  $\mathbf{u}$  and to use their “distance” as a measure of the fit. There are many different ways to define the distance between  $N$ -dimensional vectors  $\mathbf{u}$  and  $\mathbf{c}$ , some of the possibilities being analysed below.

The first possibility is to minimize the average of the absolute values of the differences of the  $x$  and  $u_i$  components,  $|x - u_i|$ , namely,

$$\min_x R_1(x) \equiv \left[ \sum_{i=1}^N |x - u_i| \right] / N. \quad (7)$$

The residual  $R_1$  is known as the *absolute residual* and its value at the mean,  $R_1(\mu_1)$ , is the well-known *absolute standard deviation*. The solution to equation (7) is given by the *median*,  $x^* = \mathcal{M}$ , the value that is above (or below) 50% of the values of  $\mathbf{u}$ . Without loss of generality, we will assume that the elements of  $\mathbf{u}$  are in ascending (or descending) order. It is not difficult to see that the median can be computed as,  $\mathcal{M} = u_{(N+1)/2}$  for  $N$  odd, and  $\mathcal{M} = [u_{N/2} + u_{N/2+1}]/2$  for  $N$  even. The minimal absolute residual is then given by  $R_1(\mathcal{M})$ , from which we can measure the fit by the expression,

$$S_1 = 1 - R_1(\mathcal{M})/R_1(0). \quad (8)$$

Clearly,  $S_1 \leq 1$ , and since  $R_1(\mathcal{M})$  is the minimal residual, we also have  $S_1 \geq 0$ . The less  $R_1(\mathcal{M})$  is, the closer to one  $S_1$  will be. In particular,  $S_1 = 0$  for  $\mathcal{M} = 0$  and  $S_1 = 1$  if  $\mathbf{u}$  is a constant vector. The main drawback to work with the first-order “semblance” function  $S_1$  is that it is a non-differentiable function. Moreover, there is no closed form for  $S_1$ , in the sense that we need to first compute  $\mathcal{M}$  and then compute the residual.

Let us next analyse a second-order type semblance function. It is a well-known result that the mean,  $x^* = \mu_1$ , is the solution of the quadratic (least-squares) optimization problem,

$$\min_x R_2(x) \equiv \left[ \sum_{i=1}^N (x - u_i)^2 \right] / N. \quad (9)$$

To see this, observe that  $(dR_2/dx)(x) = 0$  is equivalent to  $\sum_{i=1}^N (x - u_i) = 0$ . Since  $(d^2R_2/dx^2)(x) = 2/N > 0$ , the zero of the derivative is the global minimizer. In other words, the mean is the value that minimizes the root-mean-square (RMS) residual,  $\sqrt{R_2(x)}$ . Substituting  $x^* = \mu_1$  in the residual  $R_2$  we find

$$R_2(\mu_1) = \left[ \sum_{i=1}^N (u_i - \mu_1)^2 \right] / N = \sigma_2, \quad (10)$$

i.e., the minimal quadratic residual equals the second central moment. As in the previous case, we can define the relative measure of the fit as

$$S_2 = 1 - R_2(\mu_1)/R_2(0) = 1 - \sigma_2/\mu_2 = \mu_1^2/\mu_2. \quad (11)$$

Note that this defines the “true” second-order semblance function in correspondence with equations (2), (3), and (4). Observe that, as in the case of the absolute residual,  $0 \leq S_2 \leq 1$ , with  $S_2 = 0$  if  $\mu_1 = 0$  and  $S_2 = 1$  if

$\mathbf{u}$  is a constant vector. The semblance function can also be interpreted as the square of the cosine of the angle  $\theta$  between the amplitude vector  $\mathbf{u}$  and the constant vector  $\mathbf{c} = (\mu_1, \mu_1, \dots, \mu_1)$ ,

$$\cos^2 \theta = \frac{\left( \sum_{i=1}^N u_i \mu_1 \right)^2}{\left( \sum_{i=1}^N u_i^2 \right) \left( \sum_{i=1}^N \mu_1^2 \right)} = \frac{(N \mu_1^2)^2}{(N \mu_2)(N \mu_1^2)} = \frac{\mu_1^2}{\mu_2} = S_2. \quad (12)$$

Increasing the order of the residual to four, let us now consider the optimization problem,

$$\min_x R_4(x) \left[ \sum_{i=1}^N (x - u_i)^4 \right] / N, \quad (13)$$

i.e., we are now attempting to minimize the fourth-order (quartic) residual. Although the above minimization problem is very similar to its second-order counterpart (9), an explicit optimal solution in this case cannot be easily found. In fact, it involves the solution of the cubic polynomial equation,  $dR_4(x)/dx = 4(x^3 - 3\mu_1 x^2 + 3\mu_2 x - \mu_3)/N = 0$ . The unique real solution,  $x^* = \kappa$ , can be computed using Cardano's formula, but the final expression cannot be easily manipulated. The same applies for the quartic residual function  $R_4$  and the corresponding semblance function. This makes a fourth-order semblance function defined through the deviation of the minimum residual hard to use.

However, there is another, computationally more appealing way of defining a fourth-order semblance-like function. For this purpose, we replace the optimal quartic residual,  $R_4(\kappa)$ , by the *quartic residual at the mean*,

$$R_4(\mu_1) = \left[ \sum_{i=1}^N (u_i - \mu_1)^4 \right] / N = \sigma_4, \quad (14)$$

which is equal to the fourth-order central moment  $\sigma_4$ . Computing the relative quartic residual, as we have done for the absolute and quadratic residuals, we obtain

$$S_4 = 1 - R_4(\mu_1)/R_4(0) = \mu_1(4\mu_3 - 6\mu_1\mu_2 + 3\mu_1^3)/\mu_4, \quad (15)$$

which is the expression for the fourth-order semblance function,  $S_4$ , given by equation (5). As in the cases of  $S_1$  and  $S_2$ , we also note that  $S_4 \leq 1$ . However, we cannot ensure that  $S_4 \geq 0$ , since  $R_4(\mu_1)$  is not the minimal quartic residual. In any case,  $S_4 = 1$  only if  $\mathbf{u}$  is a constant vector, as desirable, and  $S_4 = 0$  if  $\mu_1 = 0$  as before.

### Application to CRS Stack

The common reflection surface (CRS) method (see, e.g., Hubral et al., 1998) represents a natural extension of the Common Midpoint (CMP) method in two important aspects. Firstly, for each stacking trace location (now called simply a central point), the CRS considers a supergather of source-receiver pairs, arbitrarily located with respect to the central point. In other words, the gather is not restricted to the CMP condition. Secondly, not only the stacking velocity, but also other additional parameters are extracted from

the data. In the 2D situation, three parameters are determined for each central point and all zero-offset (ZO) traveltime samples. The procedure is performed for all traveltime samples.

To be able to stack traces from source-receiver pairs that do not conform to the CMP condition, the CRS method utilizes the (generalized) hyperbolic moveout,

$$T(x, h)^2 = [T_0 + A(x - x_0)]^2 + B(x - x_0)^2 + C h^2, \quad (16)$$

where  $x_0$  is the central point,  $x$  and  $h$  denote the midpoint and half-offset coordinates of the source and receiver pair, and  $T_0$  is the ZO traveltime at the central point. As shown in Hubral et al. (1998), the parameters  $A$ ,  $B$  and  $C$  are related to physical quantities referred to as the CRS parameters or attributes,  $A = [2 \sin \beta]/v_0$ ,  $B = [2T_0 K_N \cos^2 \beta]/v_0$ , and  $C = [2T_0 K_{NIP} \cos^2 \beta]/v_0$ , where  $\beta$  is the emergence angle of the ZO ray with respect to the surface normal,  $K_N$  and  $K_{NIP}$  are the curvatures of the N- and NIP-waves, respectively, and  $v_0$  denotes the surface velocity (see Hubral (1983)). All these quantities are evaluated at the central point.

The search for the parameters  $A$ ,  $B$  and  $C$  can be performed in three main steps. First, for each pair  $(x_0, T_0)$ , we find the value of the parameter  $C$  that maximizes the semblance function ( $S_1$ ,  $S_2$  or  $S_4$ ) for the amplitudes along the hyperbolic traveltime within the respective CMP section at  $x_0$ . Denoting this CMP section by  $\phi(h, t)$ , we can write that the vector,  $\mathbf{u} = (u_i)$ , is given by  $u_i = \phi(h_i, T_i)$ , with  $T_i = T(x_0, h_i) = \sqrt{T_0^2 + C h_i^2}$ ,  $i = 1, \dots, N_C$ , where  $N_C$  is the number of traces considered inside some aperture. After determination of all parameters,  $C$ , the CMP data is stacked. The result of this first-step process is, then, a panel  $C(x_0, T_0)$ , as well as a stacked section,  $\psi(x_0, T_0)$ .

The second step consists of the search for parameter  $A$ , performed within the stacked section  $\psi(x_0, T_0)$ . For each pair,  $(x_0, T_0)$ , we maximize the semblance  $S_1$ ,  $S_2$  or  $S_4$  of the amplitudes along the hyperbolic traveltime (16) considering  $h = 0$  and  $B = 0$ . In other words, the sample vector,  $\mathbf{u} = (u_i)$ , is now given by  $u_i = \psi(x, T_i)$ , with  $T_i = T(x, 0) = T_0 + A(x - x_0)$ ,  $i = 1, \dots, N_A$ , where  $N_A$  is again the number of traces considered inside some aperture, now taken in the stacked section. Generally,  $N_A$  will be different from  $N_C$ . Typically,  $N_A$  should be chosen smaller than  $N_C$ .

In the third step, to find  $B$ , we repeat the search in the stacked section, using the estimated value of  $A$ . For each  $(x_0, T_0)$ , we maximize the semblance for the amplitude vector,  $\mathbf{u} = (u_i)$  given by  $u_i = \psi(x, T_i)$ , with  $T_i = T(x, 0) = \sqrt{[T_0 + A(x - x_0)]^2 + B(x - x_0)^2}$ ,  $i = 1, \dots, N_C$ . Here, the aperture  $N_C$  in the stacked section must be larger than  $N_A$ .

### Numerical experiments

To compare the behaviour of the different semblance functions in the estimation of CRS parameters and stack, we have applied the procedure described in the previous section to a very simple synthetic data set. The seismic model is depicted in Figure 1. It consists of a smooth reflector below a homogeneous acoustic medium. We analyse the be-

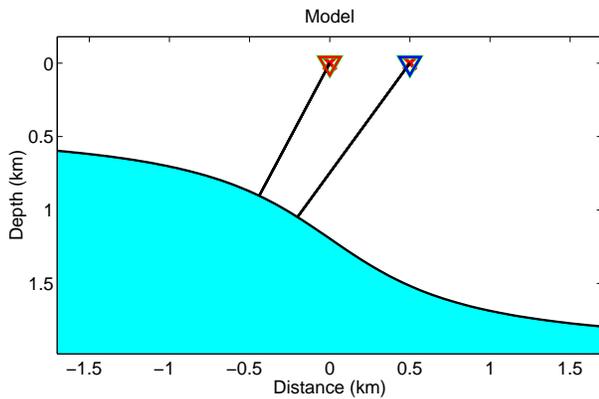


Figure 1: Model and central points for the synthetic experiments.

haviour of the three semblance functions,  $S_1$ ,  $S_2$  and  $S_4$ , for two different central points and also using the correct value of the zero-offset (ZO) (or stacked) time. Also shown in Figure 1 are the two ZO rays at the two central points. For each  $x_0$  we performed one thousand random tests for each of five different sizes of the aperture (number of traces), 10, 20, 30, 50 and 70, and for each of four noise levels, 30%, 50%, 100% and 150%, respectively. An estimate of any parameter  $A$ ,  $B$  or  $C$  is considered a success if the deviation from the true value is less than 10%.

#### Estimation of CRS parameters

The results of the search for parameter  $C$  were almost the same in all cases, with no significant advantage of using any of the semblance functions. Parameter  $C$  was successfully determined at both points  $x_0$  in over 90% of the tests, even for the highest noise level, with any of the three tested semblance functions. This confirms the well-known robustness of the parameter  $C$ .

As opposed to the previous case, significant differences between the success rate for the different semblance functions are now observed in the search for parameter  $A$ . Again, we performed one thousand random tests for each of five different sizes of the aperture (number of traces), 10, 20, 30, 50 and 70, and for each of four noise levels, 30%, 50%, 100% and 150%, respectively, at two different central points  $x_0$  in the modeled zero-offset section (see Figure 2). The sought-for results of parameter  $A$  at the two central points are the dips of the straight lines tangent to the zero-offset reflection, as depicted in Figure 2.

Figures 3 and 4 depict the percentage of success for parameter  $A$  at  $x_0 = 5$  km and  $x_0 = 0.0$  km, respectively. As can be observed, the search using  $S_4$  has a higher success rate in almost every setting. The largest advantage of the fourth-order semblance function is observed, as expected, at the highest noise level.

Another conclusion from Figures 3 and 4 is that the search for  $A$  is highly dependent on the chosen aperture. While there is a high success rate for all aperture sizes at the central point  $x_0 = 0$  km, the same is not true at the central point  $x_0 = 0.5$  km. The reason is the stronger curvature

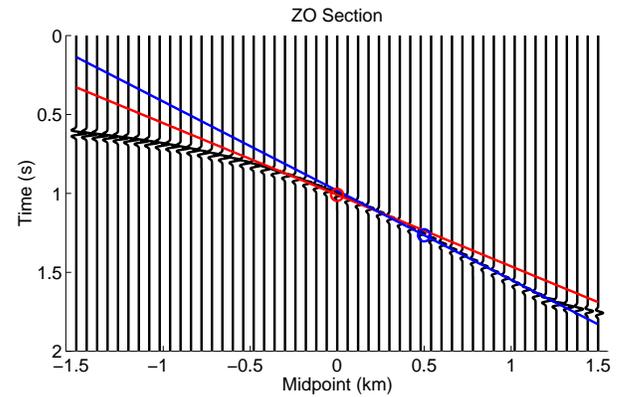


Figure 2: Zero-offset section for the model in Figure 1. Every 3rd trace is shown

of the reflection event at  $x_0 = 0.5$  km (see again Figure 2), which makes it harder to fit a linear traveltim curve over a larger aperture. Interestingly enough, an aperture of about 20 traces seems to work best at both central points, even though Figure 2 indicates that around  $x_0 = 0.5$  km, the traveltim function is approximately linear over a larger interval. For this example, the aperture of 20 traces is equivalent to about half the depth of the reflection point.

The final step is the detection of  $B$  in the zero-offset section using the estimated values of  $A$ . Once more, we performed one thousand random tests for each of five different sizes of the aperture (number of traces), 10, 20, 30, 50 and 70, and for each of four noise levels, 30%, 50%, 100% and 150%, respectively, in the modeled zero-offset section (see Figure 2). Since our interest was in the different performances of the different semblance functions, we carried out the set of experiments using the exact value for  $A$  in the search for  $B$  in order not to let the error in the estimation of  $A$  influence the estimation of  $B$ . As in the search for  $C$ , we found no significant differences in success rate for  $B$ . However, while the search for  $C$  was very robust, yielding high success rates for any of the semblance functions, the search for  $B$  is rather unstable and the success rates are quite low, particularly for high noise levels. Instability of parameter  $B$  is a well-known difficulty encountered by the CRS method.

#### Behaviour of stacked sections

The second experiment was devised to exemplify the different behaviour of the CRS stacked sections obtained using the different semblance functions. Due to the rather poor performance of  $S_1$  in the statistical tests, and since the standard procedure is to use  $S_2$ , we only compare the results using  $S_2$  and  $S_4$ . We applied the CRS stacking technique to a complete synthetic dataset for a model with three homogeneous layers separated by one curved and two horizontal interfaces. To study the behaviour of the semblance functions we simulated two types of noise. In the first test, we added white noise of about 60% of the data amplitude. For the second test, we used a lower noise level of about 30%, but convolved it with a Ricker wavelet so as to simulate colored rather than white noise.

Figure 5 shows the CRS stacked sections for the first test

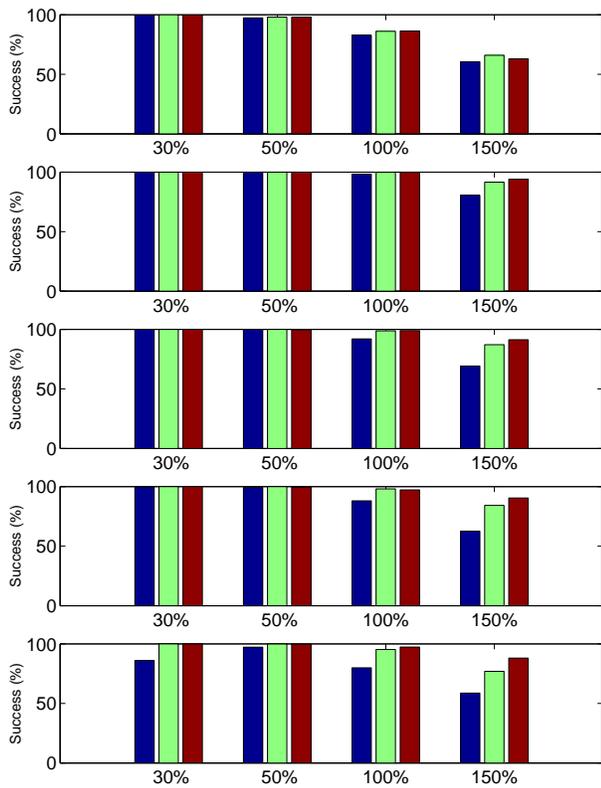


Figure 3: Percentage of success in finding parameter  $A$  in the ZO-section for  $x_0 = 0.5$  km:  $S_1$  (blue),  $S_2$  (green) and  $S_4$  (red). From top to bottom the number or traces within the aperture increases: 10, 20, 30, 50 and 70. The ratio aperture/depth also increases: 0.3, 0.5, 0.8, 1.0 and 1.5. In the horizontal axis is indicated the level of the added noise: 30%, 50%, 100%, and 150%.

data set. The left column shows the results of using  $S_2$  and the right column those of  $S_4$ . In the top row, we see the stacked sections after the search for  $C$ . Though the first reflector is slightly better visible in the  $S_4$  section, the overall impression is of comparable quality. This is the expected result after the above statistical tests.

In the center row of Figure 5, we see the stacked sections after the search of  $A$ . This search is performed in the sections shown in the top row. As expected from the statistical analysis, the search for  $A$  was much more successful when using  $S_4$ . The second and third reflectors are much better visible in the right panel than in the left one. As the next step, the  $B$  values are searched for individually in the center panels. However, because of the small success rate of the  $B$  search, the stacked sections do not change much.

The bottom row of Figure 5 shows the final CRS stacked section after a simultaneous search for the best triplet of values  $A$ ,  $B$ , and  $C$ . The previously detected individual values of  $A$ ,  $B$ , and  $C$  are used as initial values for this search. The higher quality of the right panel is clearly visible. The main reason for the better quality of the final stacked section are the better initial values for the simultaneous search, particularly  $A$ . The search itself is rather

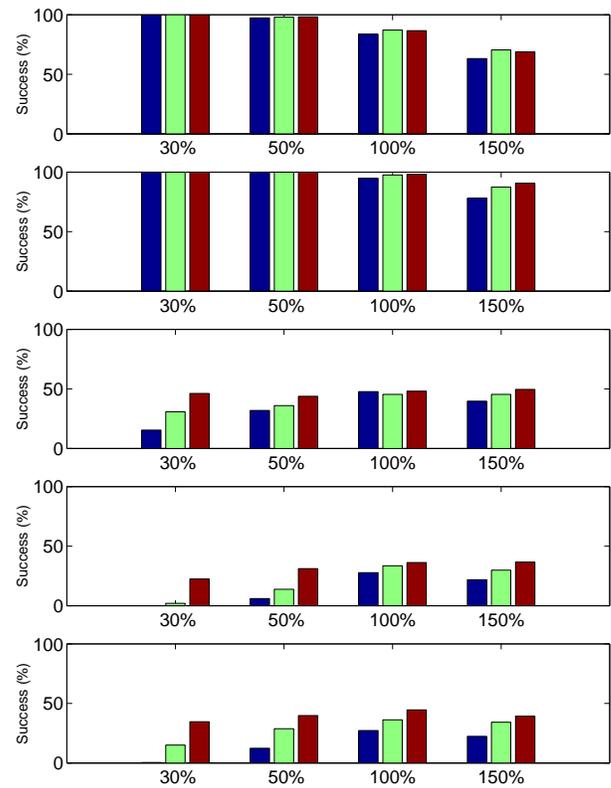


Figure 4: Percentage of success in finding parameter  $A$  in the ZO-section for  $x_0 = 0.0$  km:  $S_1$  (blue),  $S_2$  (green) and  $S_4$  (red). From top to bottom the number or traces within the aperture increases: 10, 20, 30, 50 and 70. The ratio aperture/depth also increases: 0.3, 0.5, 0.8, 1.0 and 1.5. In the horizontal axis is indicated the level of the added noise: 30%, 50%, 100%, and 150%.

independent of the choice of the semblance function. Simultaneous search with  $S_2$  using the initial values from the  $S_4$  individual searches results in a stacked section of comparable quality.

Figure 6 shows the corresponding results for the second test with colored noise. While the overall observations remain very similar, we note that even the search for  $C$  seems to be more stable with the fourth-order semblance. Apparently, the presence of colored noise in the data is more of a disturbance to a standard  $S_2$  coherence analysis than to the one using  $S_4$ .

## Conclusions

In this paper, we have introduced a new fourth-order semblance function. Moreover, we have evaluated its behaviour in CRS parameter estimation and stack. We have seen that the new fourth-order semblance function produces comparable results for the searches of the curvature parameters, but superior results for the linear search. The fourth-order measure is less dependent on aperture and noise level, thus resulting in reliable estimates of the local slope more often than when using conventional semblance. As a consequence, the fourth-order-semblance based final CRS stack after the whole search procedure is of better quality

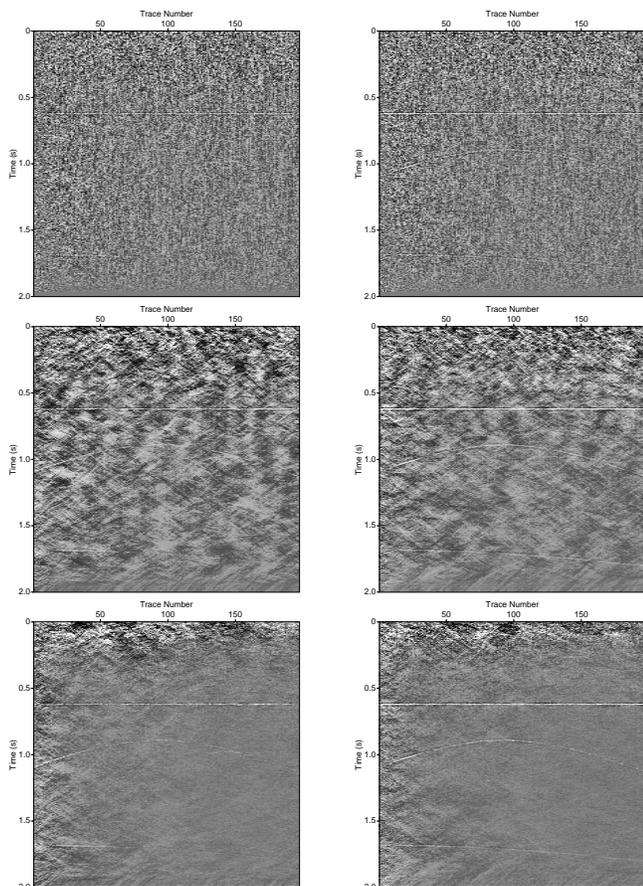


Figure 5: Stacked sections after the searches, with 60% white noise. Top:  $C$ . Center:  $A$ . Bottom: Simultaneous. Left:  $S_2$ . Right:  $S_4$ .

than the corresponding one based on second-order semblance stack.

Another conclusion from our analysis is that the linear search is highly dependent on the chosen aperture. Depending on the curvature of the reflection event in the stacked section, the success rate can decrease dramatically with increasing aperture. For our examples, an aperture of about half the depth of the reflection point produced the best results.

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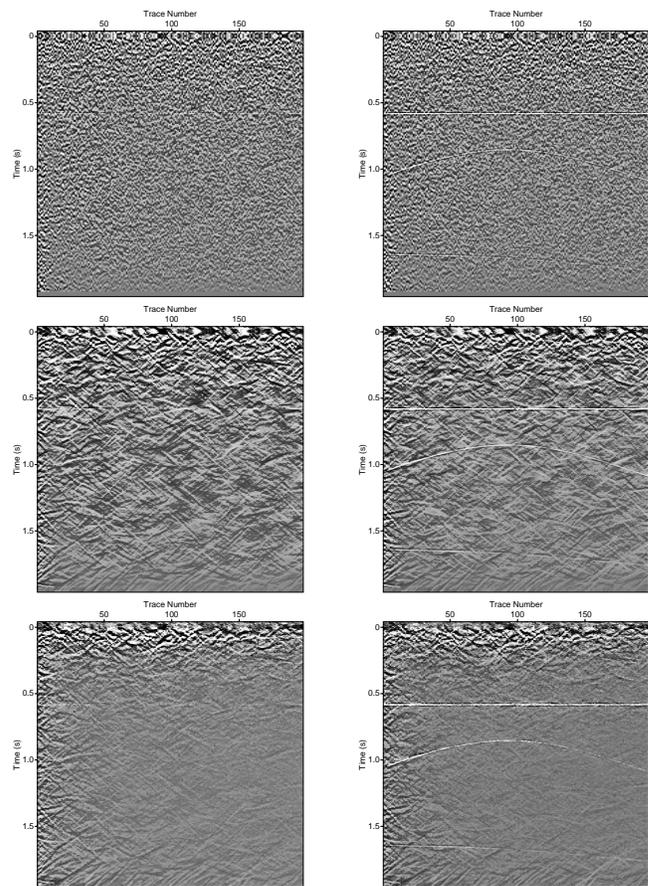


Figure 6: Stacked sections after the searches, with 30% colored noise. Top:  $C$ . Center:  $A$ . Bottom: Simultaneous. Left:  $S_2$ . Right:  $S_4$ .

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